Search Notes

Δ	application/Control No.	Applicant(s)/Patent Reexamination	under
1	0/517,232	LIM, NAG-BOK	
E	xaminer	Art Unit	
	Christopher Bottorff	3618	

	SEARCHED				
Class	Subclass	Date	Examiner		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
180	9.26	8/30/07	CDB	
J	907			
280	5,22			
	5,22 250.1	V	V	

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